

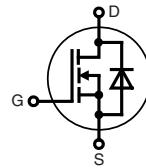
# CoolMOS™<sup>1)</sup> Power MOSFET

N-Channel Enhancement Mode

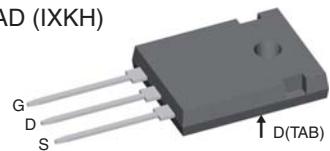
Low  $R_{DS(on)}$ , High  $V_{DSS}$  MOSFET

Ultra low gate charge

$I_{D25} = 70\text{ A}$   
 $V_{DSS} = 600\text{ V}$   
 $R_{DS(\text{on})\text{ max}} = 0.045\Omega$



TO-247 AD (IXKH)



## MOSFET

Symbol	Conditions	Maximum Ratings		
$V_{DSS}$	$T_{VJ} = 25^\circ\text{C}$	600		V
$V_{GS}$		$\pm 20$		V
$I_{D25}$	$T_C = 25^\circ\text{C}$	70		A
$I_{D90}$	$T_C = 90^\circ\text{C}$	48		A
$E_{AS}$ $E_{AR}$	single pulse repetitive } $I_D = 11\text{ A}; T_C = 25^\circ\text{C}$	1950	mJ	
$E_{AS}$ $E_{AR}$		3	mJ	
$dV/dt$	MOSFET dV/dt ruggedness $V_{DS} = 0\text{...}480\text{ V}$	50	V/ns	

## Symbol Conditions

## Characteristic Values

( $T_{VJ} = 25^\circ\text{C}$ , unless otherwise specified)

		min.	typ.	max.
$R_{DS(on)}$	$V_{GS} = 10\text{ V}; I_D = 44\text{ A}$	40	45	$\text{m}\Omega$
$V_{GS(\text{th})}$	$V_{DS} = V_{GS}; I_D = 3\text{ mA}$	2.5	3	3.5
$I_{DSS}$	$V_{DS} = 600\text{ V}; V_{GS} = 0\text{ V}$ $T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	50	10	$\mu\text{A}$
$I_{GSS}$	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0\text{ V}$		100	$\text{nA}$
$C_{iss}$ $C_{oss}$	$V_{GS} = 0\text{ V}; V_{DS} = 100\text{ V}$ $f = 1\text{ MHz}$	6800 320		$\text{pF}$
$Q_g$ $Q_{gs}$ $Q_{gd}$	$V_{GS} = 0\text{ to }10\text{ V}; V_{DS} = 400\text{ V}; I_D = 44\text{ A}$	150 35 50	190	$\text{nC}$
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	$V_{GS} = 10\text{ V}; V_{DS} = 400\text{ V}$ $I_D = 44\text{ A}; R_G = 3.3\Omega$	30 20 100 10		ns
$R_{thJC}$			0.2	K/W

## Features

- fast CoolMOS™<sup>1)</sup> power MOSFET 4<sup>th</sup> generation
  - High blocking capability
  - Lowest resistance
  - Avalanche rated for unclamped inductive switching (UIS)
  - Low thermal resistance due to reduced chip thickness
- Enhanced total power density

## Applications

- Switched mode power supplies (SMPS)
- Uninterruptible power supplies (UPS)
- Power factor correction (PFC)
- Welding
- Inductive heating
- PDP and LCD adapter

<sup>1)</sup> CoolMOS™ is a trademark of Infineon Technologies AG.

**Source-Drain Diode**

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$I_s$	$V_{GS} = 0 \text{ V}$			44 A
$V_{SD}$	$I_F = 44 \text{ A}; V_{GS} = 0 \text{ V}$	0.9	1.2	V
$t_{rr}$ $Q_{RM}$ $I_{RM}$	$I_F = 44 \text{ A}; -di_F/dt = 100 \text{ A}/\mu\text{s}; V_R = 400 \text{ V}$	600 17 60		ns $\mu\text{C}$ A

**Component**

Symbol	Conditions	Maximum Ratings		
$T_{VJ}$	operating	-55...+150		°C
$T_{stg}$		-55...+150		°C
$M_d$	mounting torque	0.8 ... 1.2		Nm

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$R_{thCH}$	with heatsink compound	0.25		K/W
Weight		6		g

## TO-247 AD Outline

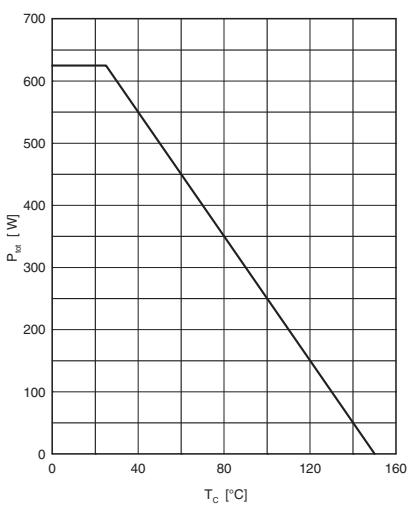
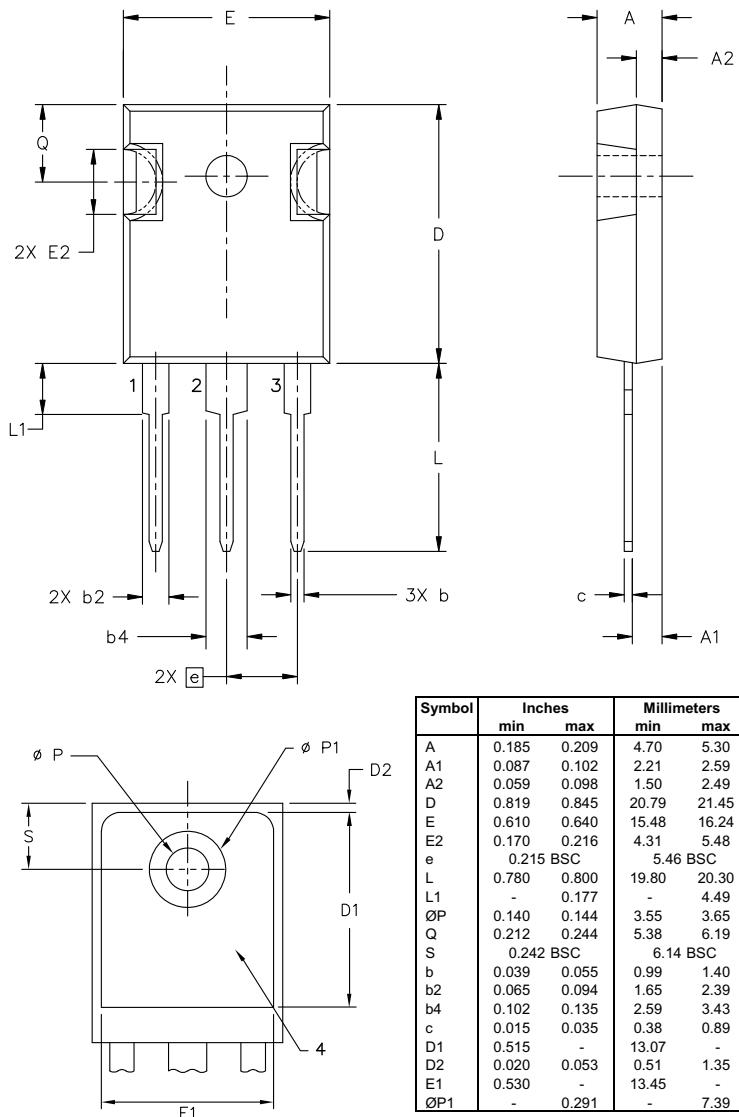


Fig. 1 Power dissipation

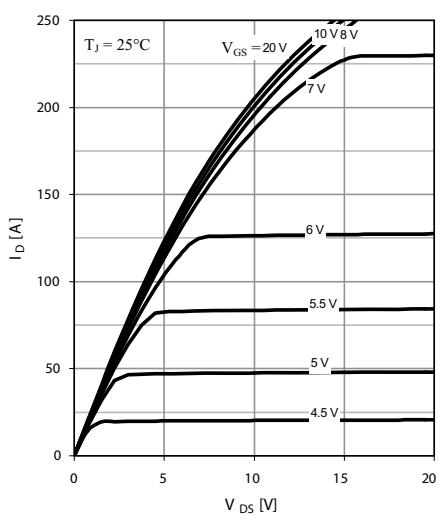


Fig. 2 Typ. output characteristics

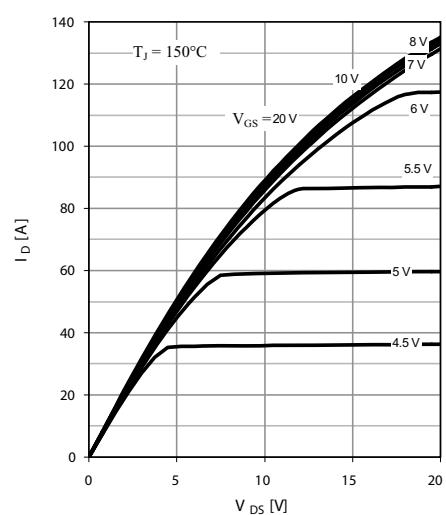


Fig. 3 Typ. output characteristics

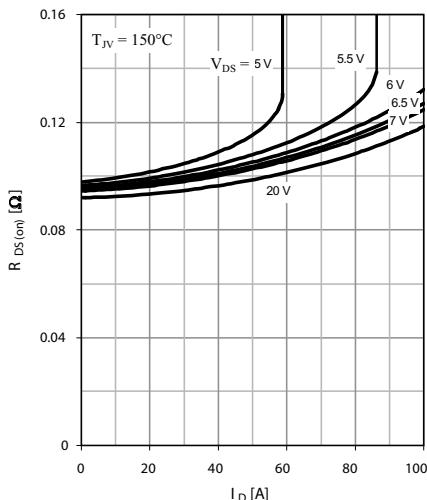


Fig. 4 Typ. drain-source on-state resistance characteristics of IGBT

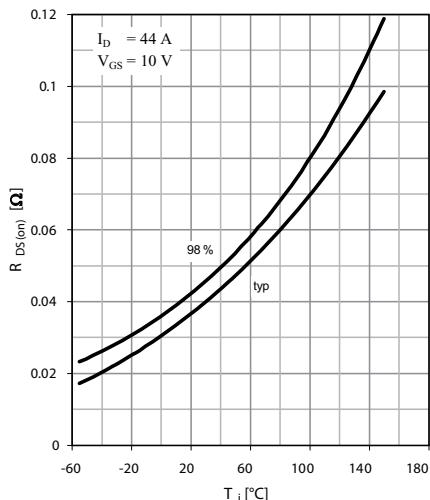


Fig. 5 Drain-source on-state resistance

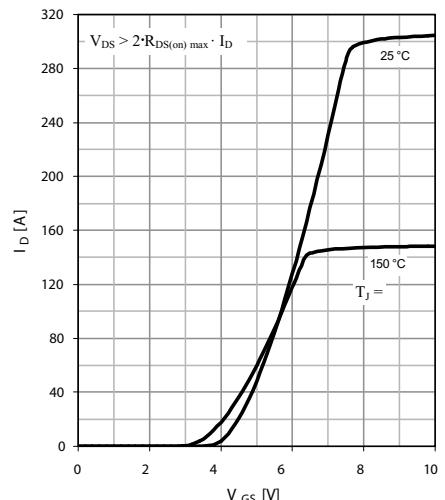


Fig. 6 Typ. transfer characteristics

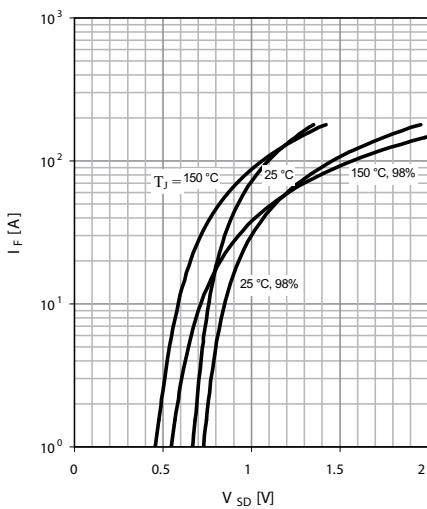


Fig. 7 Forward characteristic of reverse diode

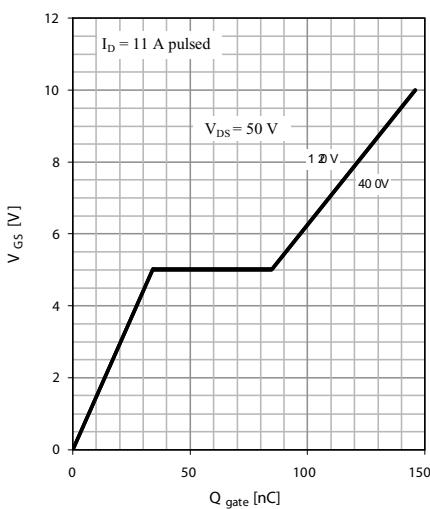


Fig. 8 Typ. gate charge

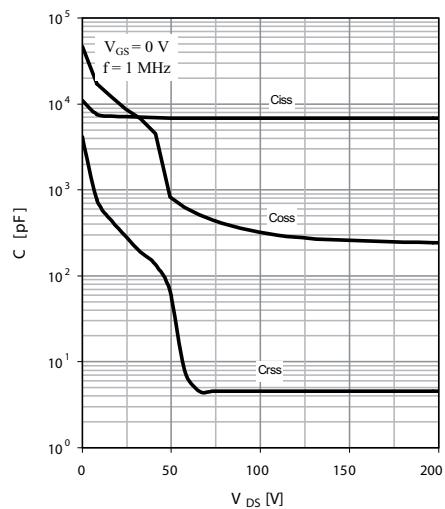


Fig. 9 Typ. capacitances

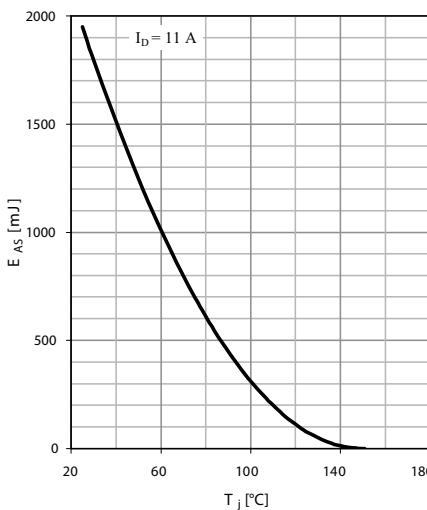


Fig. 10 Avalanche energy

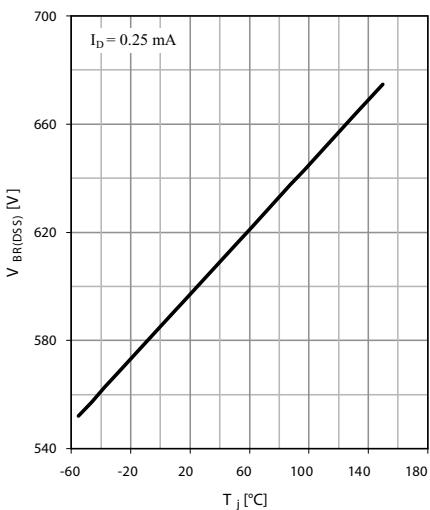


Fig. 11 Drain-source breakdown voltage

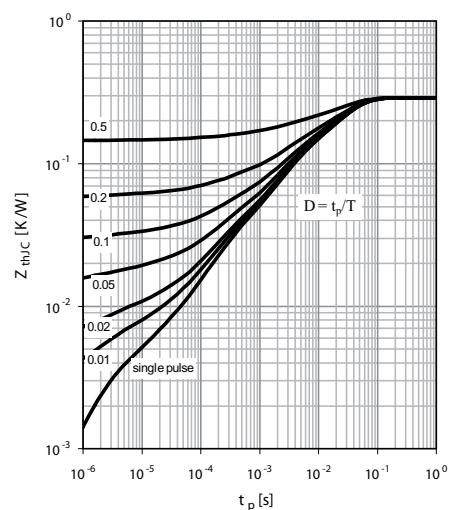


Fig. 12 Max. transient thermal impedance

IXYS reserves the right to change limits, test conditions and dimensions.



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